

L Number	Hits	Search Text	DB	Time stamp
49	90	(fifo same (dram or (dynamic adj (ram or random)))) and (semiconductor with (dram or (dynamic adj (ram or random))))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/17 07:42
50	18	(fifo same (dram or (dynamic adj (ram or random)))) and ((semiconductor adj (wafer or substrate or sub-strate)) with (dram or (dynamic adj (ram or random))))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/17 07:30
51	72	((fifo same (dram or (dynamic adj (ram or random)))) and (semiconductor with (dram or (dynamic adj (ram or random)))) not ((fifo same (dram or (dynamic adj (ram or random)))) and ((semiconductor adj (wafer or substrate or sub-strate)) with (dram or (dynamic adj (ram or random))))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/17 07:30
52	44	(fifo same (dram or (dynamic adj (ram or random)))) and ((wafer or substrate or sub-strate) with (dram or (dynamic adj (ram or random))))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/17 07:38
53	26	((fifo same (dram or (dynamic adj (ram or random)))) and ((wafer or substrate or sub-strate) with (dram or (dynamic adj (ram or random)))) not ((fifo same (dram or (dynamic adj (ram or random)))) and ((semiconductor adj (wafer or substrate or sub-strate)) with (dram or (dynamic adj (ram or random))))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/17 07:38
54	19	(fifo same (dram or (dynamic adj (ram or random)))) same (substrate or sub-strate or wafer or die)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/17 07:42

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